

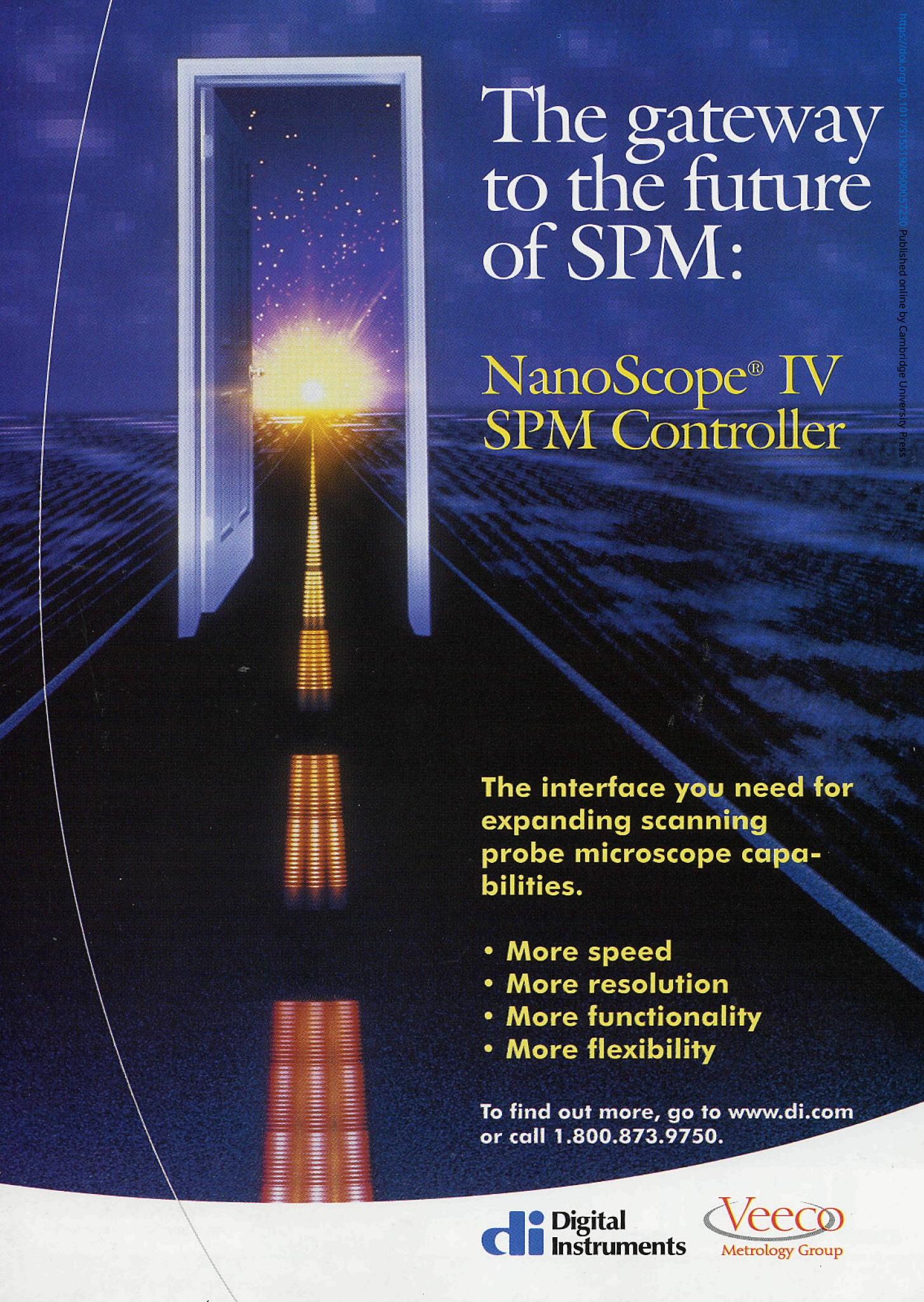
MICROSCOPY TODAY

MAY 2001

ISSUE #01-4

<https://doi.org/10.1017/S1551929500057230> Published online by Cambridge University Press





The gateway
to the future
of SPM:

NanoScope® IV SPM Controller

The interface you need for
expanding scanning
probe microscope capa-
bilities.

- More speed
- More resolution
- More functionality
- More flexibility

To find out more, go to www.di.com
or call 1.800.873.9750.

di Digital
Instruments

Veeco
Metrology Group